

# CRMTGH0602B

N-Channel 60V, 2.1mΩ Typ. Power MOSFET

### Description



• 60V, 200A

 $R_{DS(ON)}$  Typ = 2.1m $\Omega$  @ V<sub>GS</sub> = 10V

Advanced Split Gate Trench Technology

- Excellent R<sub>DS(ON)</sub> and Low Gate Charge
- 100% UIS TESTED!

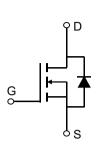
**Application** 

**PWM Application** 

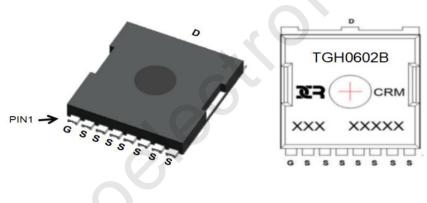
• Power Management

Load Switch

100% ΔVds TESTED!



### Schematic Diagram



#### Marking and Pin Assignment

#### Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMTGH0602B	CRMTGH0602B	TOLL	TAPING	13"	2000	10000

### Absolute Maximum Ratings (@ T<sub>J</sub> = 25°C unless otherwise specified)

			/	
Symbol	Parameter		Value	Units
$V_{\text{DS}}$	Drain-to-Source Voltage		60	V
$V_{GS}$	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	T <sub>c</sub> = 25°C	200	А
Ι <sub>D</sub>		T <sub>c</sub> = 100°C	120	А
I <sub>DM</sub>	Pulsed Drain Current <sup>(1)</sup>		800	А
E <sub>AS</sub>	Single Pulsed Avalanche Energy <sup>(2)</sup>		342	mJ
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25°C	162	W
$R_{ ext{ ext{ ext{ ext{ ext{ ext{ ext{ ext$	Thermal Resistance, Junction to Case		0.77	°C/W
T <sub>J</sub> , T <sub>stg</sub>	Junction & Storage Temperature Range		-55 to 150	°C



### **Electrical Characteristics** (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Chara	acteristics					
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V	60	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V	-	-	1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.2	2.8	3.4	V
R <sub>DS(ON)</sub>	Static Drain-Source ON-Resistance <sup>(3)</sup>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 30A	-	2.1	2.7	mΩ
Dynamic	Characteristics			5		
C <sub>iss</sub>	Input Capacitance		-	3501	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 30V, f = 1MHz	-	1089	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			14	-	pF
Q <sub>g</sub>	Total Gate Charge			56	-	nC
$Q_gs$	Gate Source Charge	$V_{GS} = 0$ to 10V $V_{DS} = 30V, I_{D} = 50A$	<b>)</b> -	25	-	nC
$Q_{gd}$	Gate Drain("Miller") Charge	$v_{\rm DS} = 30v, i_{\rm D} = 30A$	-	7	-	nC
Switchin	g Characteristics					
t <sub>d(on)</sub>	Turn-On DelayTime		-	12	-	ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>GS</sub> = 10V, V <sub>DD</sub> = 30V	-	32	-	ns
t <sub>d(off)</sub>	Turn-Off DelayTime	$I_D$ = 50A, $R_{GEN}$ = 2.7 $\Omega$	-	46	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	23	-	ns
Drain-So	urce Diode Characteristics and M	lax Ratings				
I <sub>s</sub>	Maximum Continuous Drain to Source Diode Forward Current		-	-	200	А
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	800	А
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = 30A	-	-	1.2	V
trr	Body Diode Reverse Recovery Time		-	10000	-	ns
Qrr	Body Diode Reverse Recovery Charge	I <sub>F</sub> = 50A, di/dt = 100A/us	-	38	-	nC

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

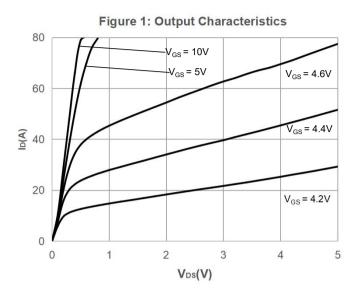
2. E<sub>AS</sub> condition: Starting T<sub>J</sub>=25°C, V<sub>DD</sub>=30V, V<sub>G</sub>=10V, R<sub>G</sub>=250hm, L=0.5mH, I<sub>AS</sub>= 37A

3. Pulse Test: Pulse Width  ${\leqslant}300\mu s,$  Duty Cycle  ${\leqslant}0.5\%.$ 



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### **Typical Performance Characteristics**



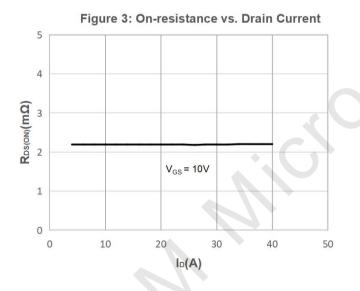
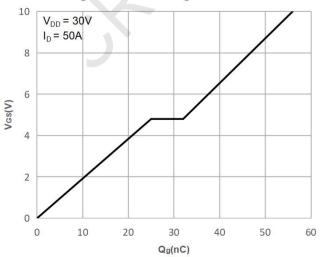


Figure 5: Gate Charge Characteristics



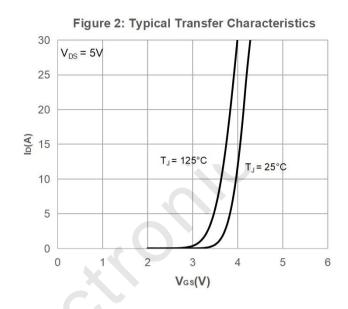


Figure 4: Body Diode Characteristics

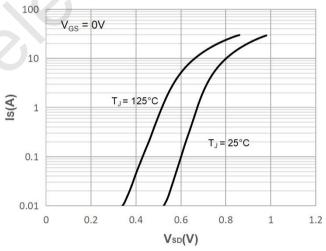
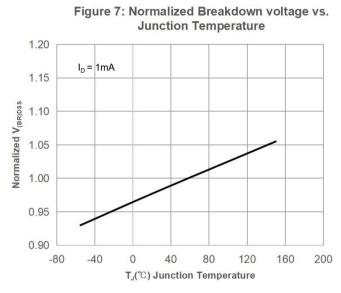


Figure 6: Capacitance Characteristics 100000 Ciss 10000 1000 Coss C(pF) 100 Crss 10 f= 1MHZ  $V_{GS} = 0V$ 1 0 5 10 15 20 25 30 35 40 45 50 55 60 VDS(V)

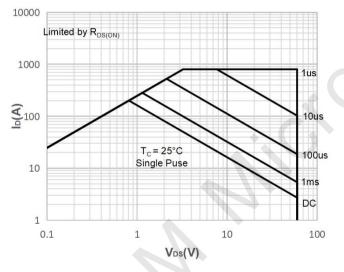


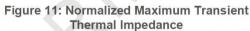
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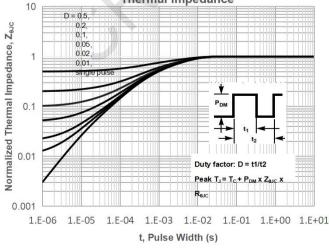
### **Typical Performance Characteristics**



#### Figure 9: Maximum Safe Operating Area







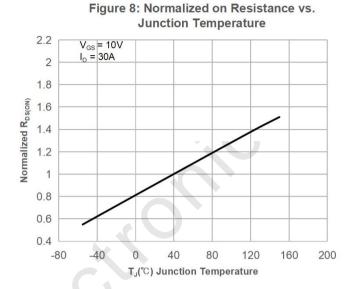


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

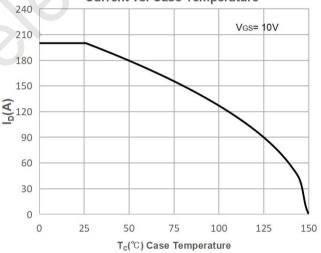
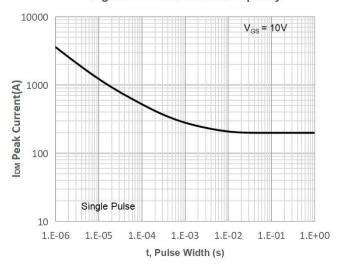


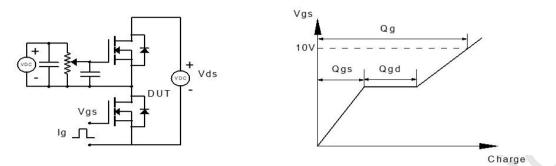
Figure 12: Peak Current Capacity



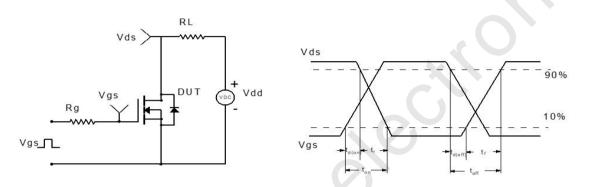


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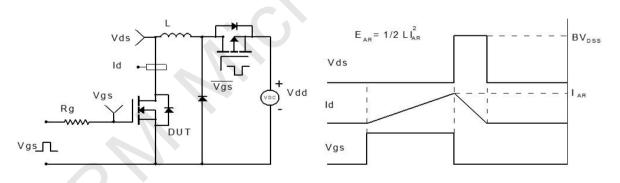
### **Test Circuit**







#### Figure 2: Resistive Switching Test Circuit & Waveform



#### Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

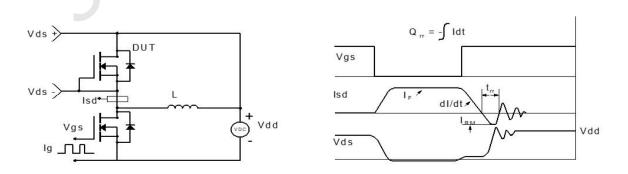
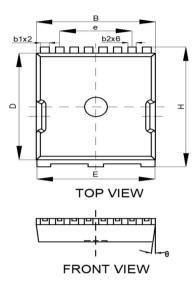
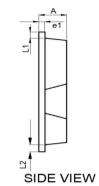


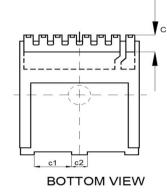
Figure 4: Diode Recovery Test Circuit & Waveform



### Package Mechanical Data(TOLL)







SYMBOL	MIN	NOM	MAX	
А	2.20	2.30	2.40	
В	9.85	9.90	9.95	
С	1.50	1.60	1.70	
D	10.40	10.50	10.60	
E	9.75	9.80	9.85	
н	11.60	11.70	11.80	
L1	0.55	0.65	0.75	
L2	0.65	0.70	0.75	
е	6.0BSC			
e1	0.45	0.50	0.55	
b1	0.70	0.75	0.80	
b2	0.60	0.70	0.80	
c1	3.00	3.10	3.20	
c2	1.10	1.20	1.30	
θ	11°			

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